



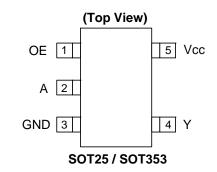
#### Description

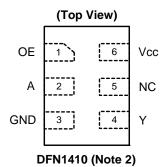
The 74LVCE1G126 is a single non-inverting buffer/bus driver with a 3-state output. The output enters a high impedance state when a LOW-level is applied to the output enable (OE) pin. The device is designed for operation with a power supply range of 1.4V to 5.5V. The inputs are tolerant to 5.5V allowing this device to be used in a mixed voltage environment. The device is fully specified for partial power down applications using  $I_{OFF}$ . The  $I_{OFF}$  circuitry disables the output preventing damaging current backflow when the device is powered down.

#### Features

- Extended Supply Voltage Range from 1.4 to 5.5V
- Switching speed characterized for operation at 1.5V
- Offers 30% speed improvement over LVC at 1.8V.
- ± 24mA Output Drive at 3.3V
- CMOS low power consumption
- IOFF Supports Partial-Power-Down Mode Operation
- Inputs accept up to 5.5V
- ESD Protection Tested per JESD 22
  Exceeds 200-V Machine Model (A115-A)
  Exceeds 2000-V Human Body Model (A114-A)
- Latch-Up Exceeds 100mA per JESD 78, Class II
- Range of Package Options
- Direct Interface with TTL Levels
- SOT25, SOT353 and DFN1410: Assembled with "Green" Molding Compound (no Br, Sb)
- Lead Free Finish/ RoHS Compliant (Note 1)

### **Pin Assignments**





#### Applications

- Voltage Level Shifting
- Bus Driver / Repeater
- Power Down Signal Isolation
- General Purpose Logic
  - Wide array of products such as.
  - PCs, networking, notebooks, netbooks, PDAs
  - o Computer peripherals, hard drives, CD/DVD ROM
  - o TV, DVD, DVR, set top box
  - o Cell Phones, Personal Navigation / GPS
  - o MP3 players ,Cameras, Video Recorders
- Notes: 1. EU Directive 2002/95/EC (RoHS). All applicable RoHS exemptions applied. Please visit our website at http://www.diodes.com/products/lead\_free.html.
  - 2. Pin 2 and pin 5 of the DFN1410 package are internally connected.

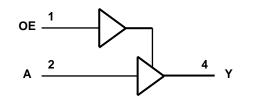


## SINGLE BUFFER GATE WITH 3-STATE OUTPUT

## **Pin Descriptions**

Pin Name	Description
OE	Output Enable (active high)
А	Data Input
GND	Ground
Y	Data Output
Vcc	Supply Voltage

## Logic Diagram



## **Function Table**

Inp	Output				
OE	-				
Н	Н	Н			
Н	L	L			
L	Х	Z			



## Absolute Maximum Ratings (Note 3)

Symbol	Description	Rating	Unit
ESD HBM	Human Body Model ESD Protection	2	KV
ESD MM	Machine Model ESD Protection	200	V
V <sub>CC</sub>	Supply Voltage Range	-0.5 to 6.5	V
VI	Input Voltage Range	-0.5 to 6.5	V
Vo	Voltage applied to output in high impedance or IOFF state	-0.5 to 6.5	V
Vo	Voltage applied to output in high or low state	-0.3 to V <sub>CC</sub> +0.5	V
I <sub>IK</sub>	Input Clamp Current V <sub>I</sub> <0	-50	mA
Ι <sub>ΟΚ</sub>	Output Clamp Current	-50	mA
Ι <sub>ο</sub>	Continuous output current	±50	mA
	Continuous current through Vdd or GND	±100	mA
TJ	Operating Junction Temperature	-40 to 150	°C
T <sub>STG</sub>	Storage Temperature	-65 to 150	°C

Note: 3. Stresses beyond the absolute maximum may result in immediate failure or reduced reliability. These are stress values and device operation should be within recommend values.

74LVCE1G126 Document number: DS32217 Rev. 2 - 2



## **Recommended Operating Conditions (Note 4)**

Symbol		Parameter	Min	Max	Unit	
N/		Operating	1.4	5.5	V	
V <sub>CC</sub>	Operating Voltage	Data retention only	1.2		V	
		$V_{\rm CC} = 1.4$ V to 1.95 V	0.65 X V <sub>CC</sub>			
	Link laurel langut Malta an	$V_{\rm CC}$ = 2.3 V to 2.7 V	1.7			
V <sub>IH</sub>	High-level Input Voltage	$V_{\rm CC} = 3  \text{V}$ to 3.6 V	2		V	
		$V_{\rm CC} = 4.5 \text{ V to } 5.5 \text{ V}$	0.7 X V <sub>CC</sub>			
		$V_{\rm CC} = 1.4$ V to 1.95 V		$0.35 \text{ X V}_{CC}$		
V		$V_{\rm CC}$ = 2.3 V to 2.7 V		0.7	V	
VIL	Low-level input voltage	$V_{\rm CC} = 3  \text{V}$ to 3.6 V		0.8	v	
		$V_{\rm CC} = 4.5 \text{ V to } 5.5 \text{ V}$		0.3 X V <sub>CC</sub>		
VI	Input Voltage	•	0	5.5	V	
Vo	Output Voltage		0	V <sub>CC</sub>	V	
		Vcc=1.4 V		-3		
	High-level output current	V <sub>CC</sub> = 1.65 V		-4		
		$V_{\rm CC} = 2.3  \rm V$		-8		
I <sub>OH</sub>				-16	mA	
		$V_{CC} = 3 V$		-24		
		$V_{CC} = 4.5 V$		-32		
		Vcc=1.4 V		3		
		V <sub>CC</sub> = 1.65 V		4		
		$V_{\rm CC} = 2.3  \rm V$		8	mA	
I <sub>OL</sub>	Low-level output current			16		
		$V_{CC} = 3 V$		24		
		$V_{\rm CC} = 4.5 \text{ V}$		32		
		$V_{CC} = 1.4 \text{ to } 3V$		20		
Δt/ΔV	Input transition rise or fall	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		10	ns/V	
	rate	$V_{\rm CC} = 5 \ V \pm 0.5 \ V$		5		
T <sub>A</sub>	Operating free-air temperature		-40	85	٥C	

Note: 4. Unused inputs should be held at Vcc or Ground.



# SINGLE BUFFER GATE WITH 3-STATE OUTPUT

## Electrical Characteristics (All typical values are at Vcc = 3.3V, T<sub>A</sub> = $25^{\circ}$ C)

Symbol	Parameter	Test Conditions	Vcc	Min	Тур.	Max	Unit	
		I <sub>OH</sub> = -100μA	1.4 V to 5.5V	$V_{CC} - 0.1$				
		I <sub>OH</sub> = -3mA	1.4 V	1.05				
		$I_{OH} = -4mA$	1.65 V	1.2				
V <sub>OH</sub>	High Level Output Voltage	I <sub>OH</sub> = -8mA	2.3V	1.9			V	
	Vollage	I <sub>OH</sub> = -16mA	3 V	2.4				
		I <sub>OH</sub> = -24mA	5 V	2.3				
		I <sub>OH</sub> = -32mA	4.5 V	3.8				
		I <sub>OL</sub> = 100μA	1.4 V to 5.5V			0.1		
		$I_{OL} = 3mA$	1.4V			.4		
		$I_{OL} = 4mA$	1.65 V			0.45		
V <sub>OL</sub>	High-level Input Voltage	$I_{OL} = 8mA$	2.3V			0.3	V	
		I <sub>OL</sub> = 16mA	3 V			0.4		
		$I_{OL} = 24mA$	5 v			0.55		
		I <sub>OL</sub> = 32mA	4.5			0.55		
I <sub>I</sub>	Input Current	$V_1 = 5.5 \text{ V or GND}$	0 to 5.5 V			± 5	μA	
I <sub>OFF</sub>	Power Down Leakage Current	$V_1$ or $V_0 = 5.5V$	0			± 10	μA	
I <sub>oz</sub>	Z State Leakage Current	V <sub>0</sub> =0 to 5.5V	3.6V			10	μA	
I <sub>CC</sub>	Supply Current	$V_1 = 5.5V$ of GND $I_0=0$	1.4 V to 5.5V			10	μA	
$\Delta I_{CC}$	Additional Supply Current	One input at $V_{CC}$ – 0.6 V Other inputs at $V_{CC}$ or GND	3 V to 5.5V			500	μA	
Ci	Input Capacitance	$V_i = V_{CC} - or GND$	3.3		3.5		pF	
	The second Descriptions of	SOT25	(Note 5)		204			
$\theta_{JA}$	Thermal Resistance Junction-to-Ambient	SOT353	(Note 5)		371		°C/W	
		DFN1410	(Note 5)		430			
	There is the second second	SOT25	(Note 5)		52			
$\theta_{\text{JC}}$	Thermal Resistance Junction-to-Case	SOT353	(Note 5)		143		°C/W	
	001101011-10-0036	DFN1410	(Note 5)		190		1	

Over recommended free-air temperature range (unless otherwise noted)

Note: 5. Test condition for SOT25, SOT353 and DFN1410: Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.



# SINGLE BUFFER GATE WITH 3-STATE OUTPUT

## **Switching Characteristics**

Parameter From (Input)		± 0.1V		V Vcc = 1.8 V ± 0.15V		Vcc = 2.5 V ± 0.2V		Vcc = 3.3 V ± 0.3V		Vcc = 5 V ± 0.5V		Unit	
	(Input)	(Input) (OUTPUT)	Min	Max	Min	Max	Min	Max	Min	Мах	Min	Max	
t <sub>pd</sub>	А	Y	1.7	6.9	1.1	4.8	0.4	3.6	0.4	3	0.4	3	ns

Over recommended free-air temperature range, CL = 15pF (see Figure 1)

#### Over recommended free-air temperature range, CL = 30 or 50pF as noted (see Figure 2)

Parameter	From	то	Vcc = ± 0			: 1.8 V .15V		: 2.5 V ).2V	Vcc = ± 0	3.3 V .3V		= 5 V ).5V	Unit
	(Input)	(OUTPUT)	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	•
t <sub>pd</sub>	А	Y	2.6	8	1.8	5.6	0.8	4.4	0.8	3.6	0.9	3.6	ns
t <sub>en</sub>	OE	Y	2.8	9.4	1.9	6.5	1	5.2	0.9	4.3	0.9	4.3	
t <sub>dis</sub>	OE	Y	1.6	9.8	1.1	6.8	0.8	4.4	0.8	4.5	0.9	3.7	

## **Operating Characteristics**

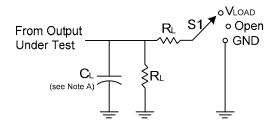
T<sub>A</sub> = 25 °C

	Parame	ter	Test Conditions	Vcc = 1.5 V TYP	Vcc = 1.8 V TYP	Vcc = 2.5 V TYP	Vcc = 3.3 V TYP	Vcc = 5 V TYP	Unit
C <sub>pd</sub>	Power dissipation	Outputs enabled	f = 10 MHz	19	19	19	19	19	pF
Upd	capacitance	Outputs disabled	1 = 10 10112	2	2	2	3	4	pΓ



## SINGLE BUFFER GATE WITH 3-STATE OUTPUT

### **Parameter Measurement Information**

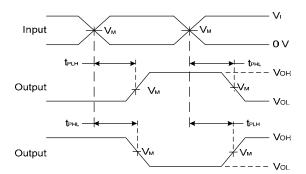


S1
Open
Vload
GND

Vcc	In	puts	Mar	C	D.
VCC	VI	t <sub>r</sub> /t <sub>f</sub>	V <sub>M</sub>	CL	RL
1.5V±0.1V	V <sub>cc</sub>	≤2ns	V <sub>CC</sub> /2	15pF	1MΩ
1.8V±0.15V	V <sub>cc</sub>	≤2ns	V <sub>CC</sub> /2	15pF	1MΩ
2.5V±0.2V	V <sub>CC</sub>	≤2ns	V <sub>CC</sub> /2	15pF	1MΩ
3.3V±0.3V	3V	≤2.5ns	1.5V	15pF	1MΩ
5V±0.5V	V <sub>CC</sub>	≤2.5ns	V <sub>CC</sub> /2	15pF	1MΩ



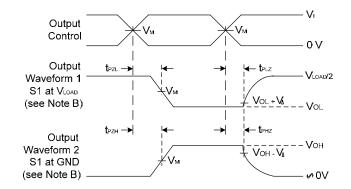
#### **Voltage Waveform Pulse Duration**



#### Voltage Waveform Propagation Delay Times Inverting and Non Inverting Outputs

- Notes: A. Includes test lead and test apparatus capacitance.
  - B. All pulses are supplied at pulse repetition rate ≤ 10 MHz.
  - C. Inputs are measured separately one transition per measurement.
  - D.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis.}$
  - E.  $t_{\text{PZL}}$  and  $t_{\text{PZH}}$  are the same as  $t_{\text{EN}}$
  - F.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{PD.}$

#### Figure 1. Load Circuit and Voltage Waveforms

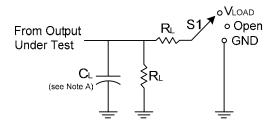


#### Voltage Waveform Enable and Disable Times Low and High Level Enabling



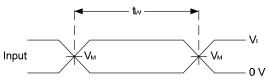
## SINGLE BUFFER GATE WITH 3-STATE OUTPUT

### Parameter Measurement Information (Continued)

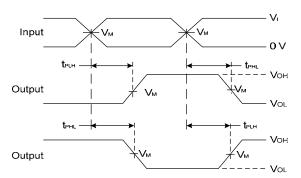


TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	Vload
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

Vcc	Ing	outs	V <sub>M</sub>	CL	RL
	Vi	t <sub>r</sub> /t <sub>f</sub>	• 141	Ϋ́́	•••
1.5V±0.1V	V <sub>CC</sub>	≤2ns	V <sub>CC</sub> /2	30pF	1KΩ
1.8V±0.15V	V <sub>CC</sub>	≤2ns	V <sub>CC</sub> /2	30pF	1KΩ
2.5V±0.2V	V <sub>cc</sub>	≤2ns	V <sub>CC</sub> /2	30pF	500Ω
3.3V±0.3V	3V	≤2.5ns	1.5V	50pF	500Ω
5V±0.5V	V <sub>CC</sub>	≤2.5ns	V <sub>CC</sub> /2	50pF	500Ω



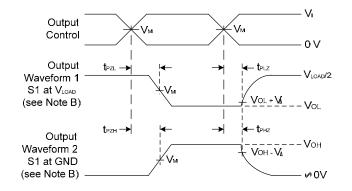
#### **Voltage Waveform Pulse Duration**



#### Voltage Waveform Propagation Delay Times Inverting and Non Inverting Outputs

- Notes: A. Includes test lead and test apparatus capacitance.
  - B. All pulses are supplied at pulse repetition rate  $\leq$  10 MHz.
  - C. Inputs are measured separately one transition per measurement.
  - D.  $t_{\mathsf{PLZ}}$  and  $t_{\mathsf{PHZ}}$  are the same as  $t_{dis.}$
  - E.  $t_{\text{PZL}}$  and  $t_{\text{PZH}}$  are the same as  $t_{\text{EN0}}$
  - F.  $t_{\mathsf{PLH}}$  and  $t_{\mathsf{PHL}}$  are the same as  $t_{\mathsf{PD.}}$

#### Figure 2. Load Circuit and Voltage Waveforms

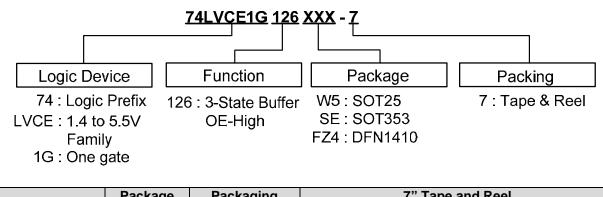


#### Voltage Waveform Enable and Disable Times Low and High Level Enabling



# SINGLE BUFFER GATE WITH 3-STATE OUTPUT

### **Ordering Information**



	Device	Package Code	Packaging (Note 5)	7" Tape and Reel		
	Device			Quantity	Part Number Suffix	
<b>Pb</b> ,	74LVCE1G126W5-7	W6	SOT25	3000/Tape & Reel	-7	
<b>Pb</b> ,	74LVCE1G126SE-7	SE	SOT353	3000/Tape & Reel	-7	
<b>Pb</b> ,	74LVCE1G126FZ4-7	FZ4	DFN1410	5000/Tape & Reel	-7	

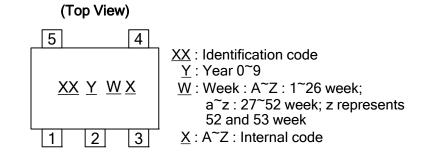
Note: 6. Pad layout as shown on Diodes Inc. suggested pad layout document AP02001, which can be found on our website at http://www.diodes.com/datasheets/ap02001.pdf.



## SINGLE BUFFER GATE WITH 3-STATE OUTPUT

### **Marking Information**

#### (1) SOT25 and SOT353



	Part Number	Package	Identification Code
Γ	74LVCE1G126W5	SOT25	PZ
	74LVCE1G126SE	SOT353	PZ

#### (2) DFN1410

#### (Top View)



- XX : Identification Code <u>Y</u> : Year : 0~9

  - $\underline{W}$ : Week : A~Z : 1~26 week; a~z: 27~52 week; z represents 52 and 53 week
  - X : A~Z : Internal code

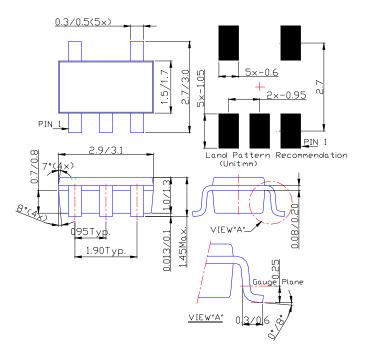
Part Number	Package	Identification Code
74LVCE1G126FZ4	DFN1410	PZ



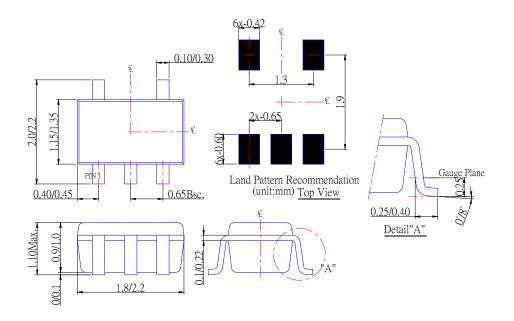
# SINGLE BUFFER GATE WITH 3-STATE OUTPUT

### Package Outline Dimensions (All Dimensions in mm)

#### (1) Package Type: SOT25



### (2) Package Type: SOT353



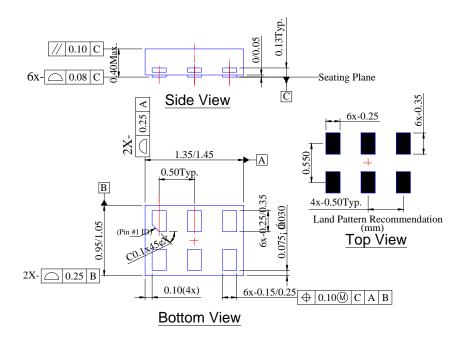
74LVCE1G126 Document number: DS32217 Rev. 2 - 2



# SINGLE BUFFER GATE WITH 3-STATE OUTPUT

## Package Outline Dimensions (All Dimensions in mm)

#### (3) Package Type: DFN1410

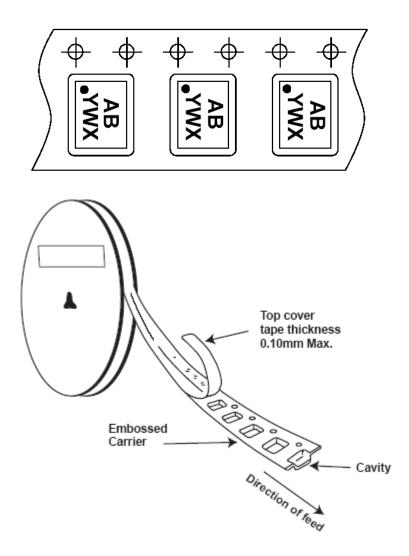


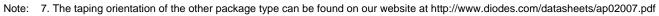


# SINGLE BUFFER GATE WITH 3-STATE OUTPUT

### Taping Orientation (Note 7)

#### For DFN1410







#### IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel.

Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

#### LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
  - 1. are intended to implant into the body, or
  - 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products or systems.

Copyright © 2010, Diodes Incorporated

www.diodes.com